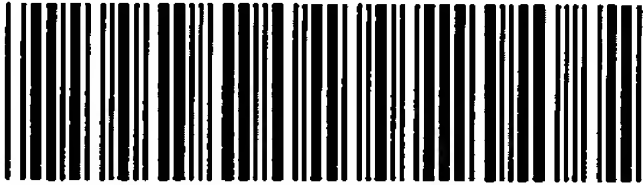


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/021,753	FUJISE ET AL.	
	Examiner	Art Unit	
	Jon Eric Angell	1635	

SEARCHED			
Class	Subclass	Date	Examiner
435	4, 6	9/16/2005	JEA
530	350	9/16/2005	JEA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN EAST Inventor Name search STIC sequence search: SEQ ID NO:1, SEQ ID NO: 2 including oligo at lest 20 amino acids long	9/15/2005	JEA